

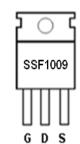
SSF1009

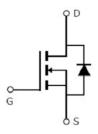
Main Product Characteristics:

V _{DSS}	100V	
R _{DS} (on)	7.2mohm(typ.)	
I _D	100A	



TO220





Schematic diagram

Features and Benefits:

- Advanced MOSFET process technology
- Special designed for PWM, load switching and general purpose applications
- Ultra low on-resistance with low gate charge
- Fast switching and reverse body recovery
- 175°C operating temperature



Marking and pin

Assignment



Description:

It utilizes the latest trench processing techniques to achieve the high cell density and reduces the on-resistance with high repetitive avalanche rating. These features combine to make this design an extremely efficient and reliable device for use in power switching application and a wide variety of other applications.

Absolute max Rating:

Symbol	Parameter	Max.	Units
I _D @ TC = 25°C	Continuous Drain Current, V _{GS} @ 10V	100 ①	
I _D @ TC = 100°C	Continuous Drain Current, V _{GS} @ 10V	72 ①	А
I _{DM}	Pulsed Drain Current 2	400	
	Power Dissipation 3	230	W
P _D @TC = 25°C	Linear Derating Factor	1.5	W/°C
V _{DS}	Drain-Source Voltage	100	V
V _{GS}	Gate-to-Source Voltage	± 20	V
E _{AS}	Single Pulse Avalanche Energy @ L=0.3mH	540	mJ
I _{AR}	Avalanche Current @ L=0.3mH	60	А
T _J T _{STG}	Operating Junction and Storage Temperature Range	-55 to + 175	°C



Thermal Resistance

Symbol	Characterizes	Тур.	Max.	Units
R _{θJC}	Junction-to-case 3	_	0.65	°C/W
В	Junction-to-ambient (t \leq 10s) (4)	_	62	°C/W
R _{θJA}	Junction-to-Ambient (PCB mounted, steady-state) ④	_	40	°C/W

Electrical Characterizes $@T_A=25^{\circ}C$ unless otherwise specified

Symbol	Parameter	Min.	Тур.	Max.	Units	Conditions	
V _{(BR)DSS}	Drain-to-Source breakdown voltage	100	_	_	V	$V_{GS} = 0V, I_D = 250 \mu A$	
D	Statia Drain to Course on registered		7.2	8	mΩ	V _{GS} =10V,I _D = 58A	
R _{DS(on)}	Static Drain-to-Source on-resistance	_	15	—		T _J = 125℃	
M	Coto throohold voltage	2	—	4	v	$V_{DS} = V_{GS}, I_D = 250 \mu A$	
V _{GS(th)}	Gate threshold voltage	—	2.21	—	V	T _J = 125℃	
	Drain to Source lookage ourrent	—	_	1		$V_{DS} = 100V, V_{GS} = 0V$	
I _{DSS}	Drain-to-Source leakage current	—	_	50	μA	$T_J = 125^{\circ}C$	
	Cate to Source forward lookang		—	100	- 0	V _{GS} =20V	
I _{GSS} Gate-to-Sour	Gate-to-Source forward leakage	-100	—	_	nA	V _{GS} = -20V	
Qg	Total gate charge	—	177	—	nC	I _D =58A,	
Q_{gs}	Gate-to-Source charge	—	37	—		V _{DS} =50V,	
Q _{gd}	Gate-to-Drain("Miller") charge		73	_		$V_{GS} = 10V$	
t _{d(on)}	Turn-on delay time		24	_			
tr	Rise time		99	_		$V_{GS}=10V, V_{DS}=65V,$ $I_{D}=58A$ $R_{GEN}=2.7\Omega$	
t _{d(off)}	Turn-Off delay time		82	_	ns		
t _f	Fall time	_	105	_			
Ciss	Input capacitance	—	6370	_		$V_{GS} = 0V$	
Coss	Output capacitance	—	422	_	pF	V _{DS} = 25V	
C _{rss}	Reverse transfer capacitance	—	375	_		f = 600KHz	

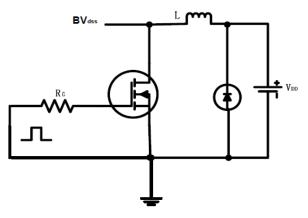
Source-Drain Ratings and Characteristics

Symbol	Parameter	Min.	Тур.	Max.	Units	Conditions
1	Continuous Source Current		— 100 ①	100 @	٨	MOSFET symb
IS	(Body Diode)	_		_		A
	Pulsed Source Current			400	^	integral reverse
I _{SM}	(Body Diode)	- 400	A	p-n junction diode.		
V _{SD}	Diode Forward Voltage	-	0.96	1.3	V	IF=58A,V _{GS} =0V,
t _{rr}	Reverse Recovery Time	_	53	_	nS	T_J = 25°C, I _F =58A, di/dt =
Q _{rr}	Reverse Recovery Charge	_	136		nC	100A/µs



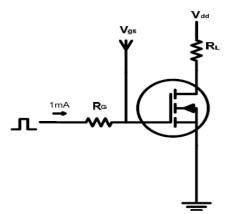
Test circuits and Waveforms

EAS test circuits:

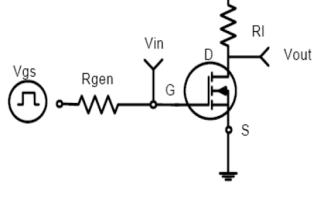


Gate charge test circuit:

Switch Waveforms:



Switch Time Test Circuit:



Vds $\overline{)}$ $\overline{$

Notes:

- ①Calculated continuous current based on maximum allowable junction temperature. Package limitation current is 75A.
- 2 Repetitive rating; pulse width limited by max. junction temperature.

Vdd

- ③The power dissipation PD is based on max. junction temperature, using junction-to-case thermal resistance.
- (4) The value of $R_{\theta JA}$ is measured with the device mounted on 1 in 2 FR-4 board with 2oz. Copper, in a still air environment with TA =25°C
- S These curves are based on the junction-to-case thermal impedence which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of $T_{J(MAX)}$ =175°C.



SSF1009



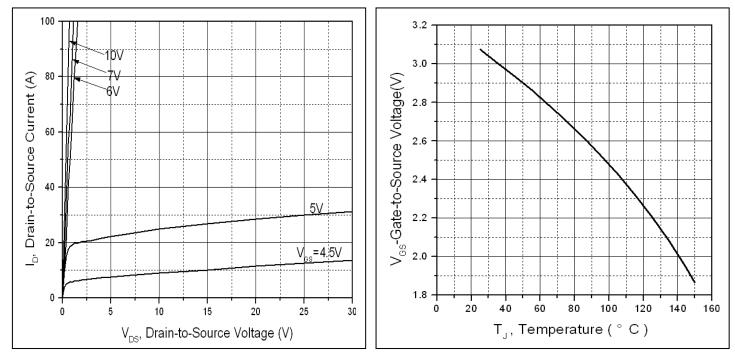


Figure 1: Typical Output Characteristics



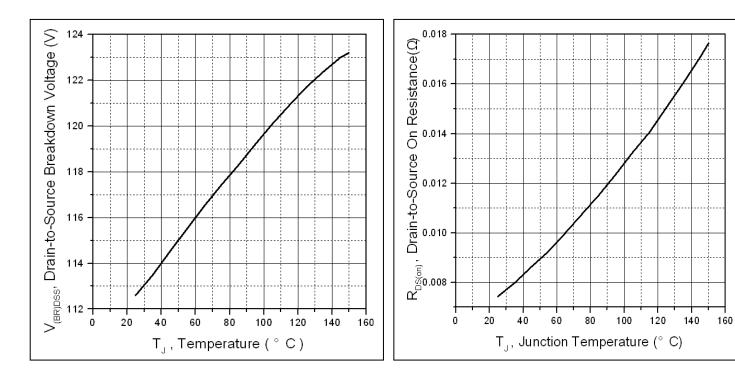
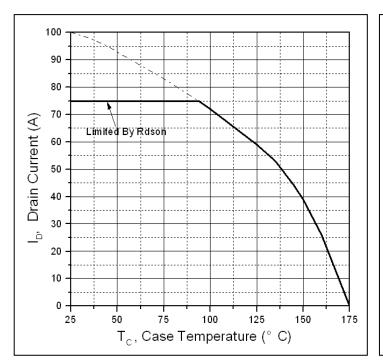




Figure 4: Normalized On-Resistance Vs. Case Temperature



SSF1009



Typical electrical and thermal characteristics



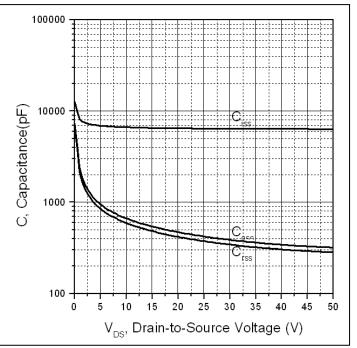


Figure 6.Typical Capacitance Vs. Drain-to-Source Voltage

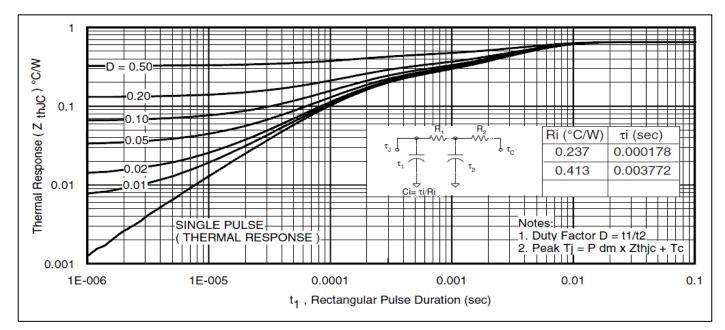
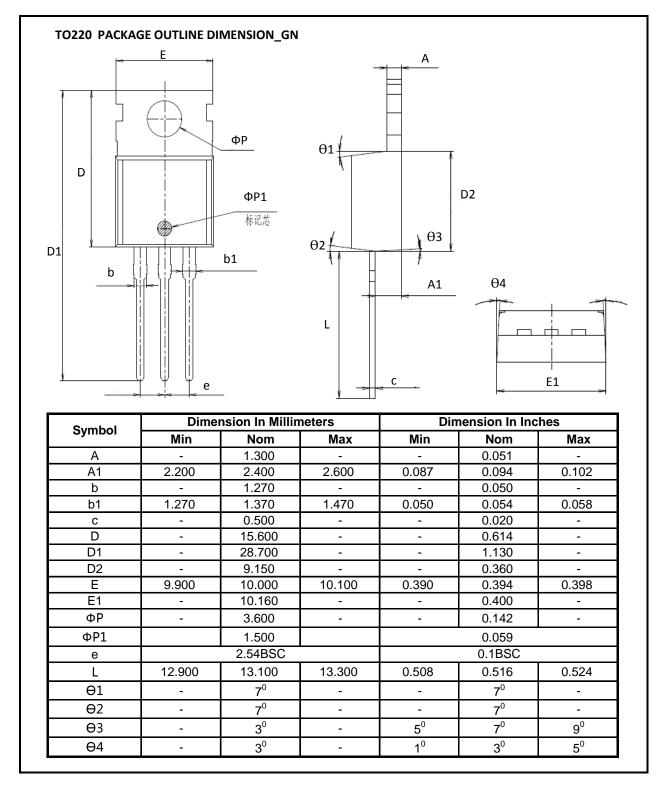


Figure7. Maximum Effective Transient Thermal Impedance, Junction-to-Case



Mechanical Data:





Ordering and Marking Information

Device Marking: SSF1009	
Package (Available)	
TO220	
Operating Temperature Range	
C : -55 to 175 ⁰C	

Devices per Unit

Package Type	Units/ Tube	Tubes/Inner Box	Units/Inner Box	Inner Boxes/Carton Box	Units/Carton Box
TO220	50	20	1000	6	6000

Reliability Test Program

Test Item	Conditions	Duration	Sample Size
High	T _j =125℃ to 175℃ @	168 hours	3 lots x 77 devices
Temperature	80% of Max	500 hours	
Reverse	V _{DSS} /V _{CES} /VR	1000 hours	
Bias(HTRB)			
High	T _j =150℃ or 175℃ @	168 hours	3 lots x 77 devices
Temperature	100% of Max V _{GSS}	500 hours	
Gate		1000 hours	
Bias(HTGB)			





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